Docket #: P/2699-26
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DIELECTRIC CONSTANT MEASURING METHOD, FILM THICKNESS
MEASURING APPARATUS, AND RELATIVE DIELECTRIC CONSTANT
MEASURING APPARATUS
Inventors: T. Kitajima et al.
Drawings 4 sheets (Figs. 1-5)
Contact: J. Finder (212) 382-0700

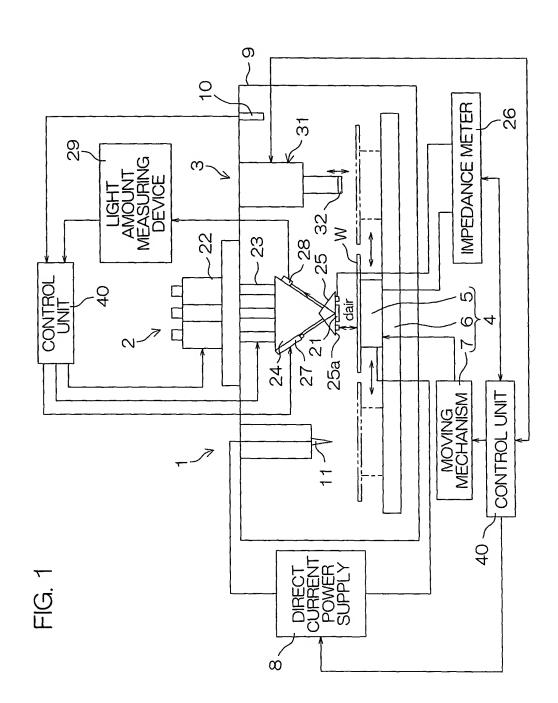
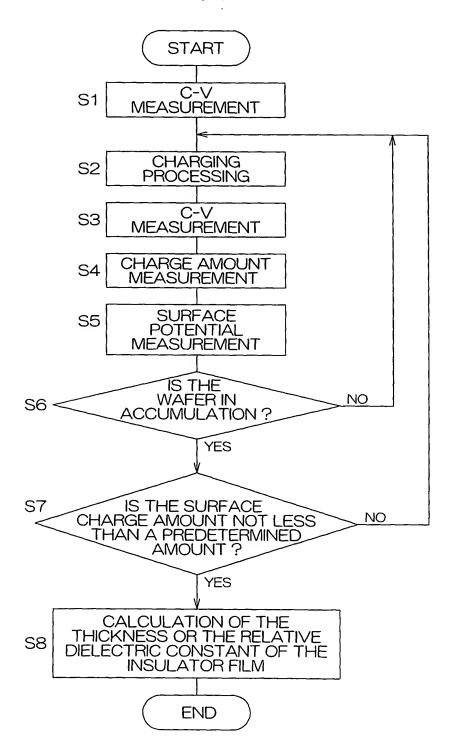
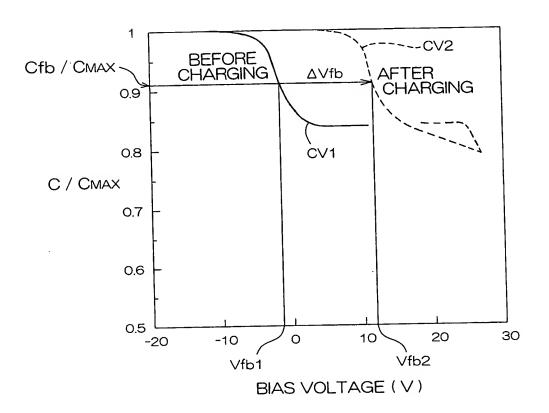


FIG. 2



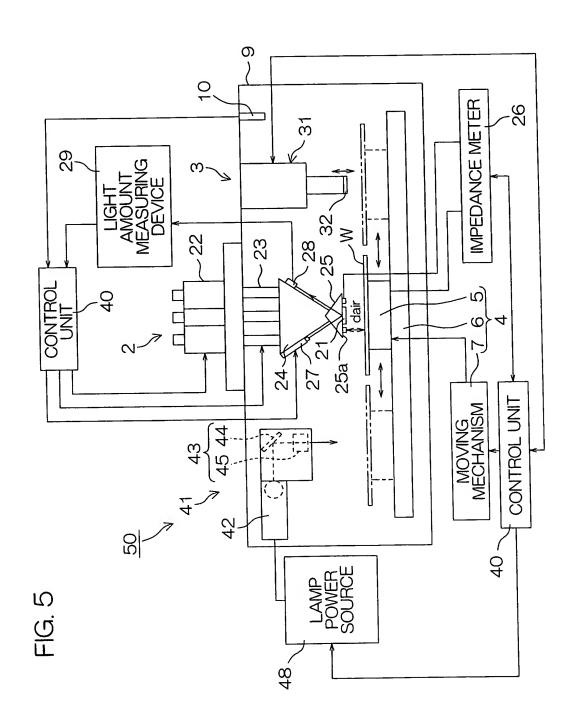
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FIG. 3

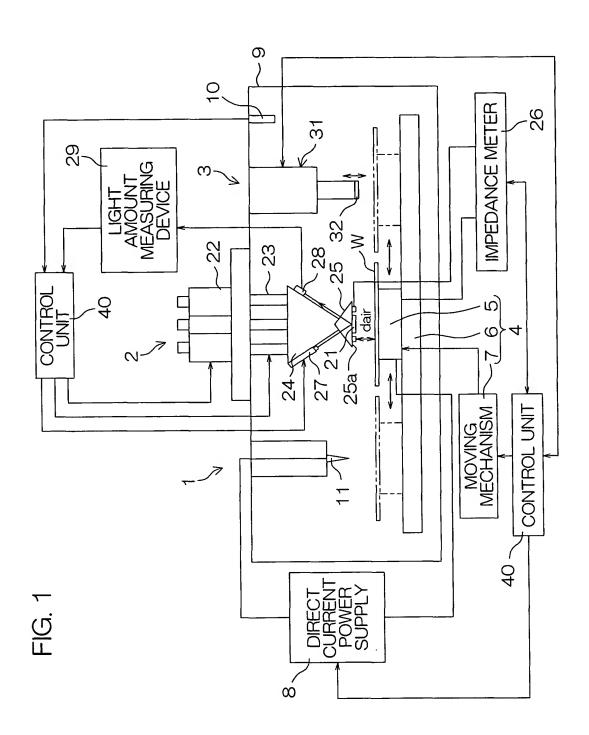


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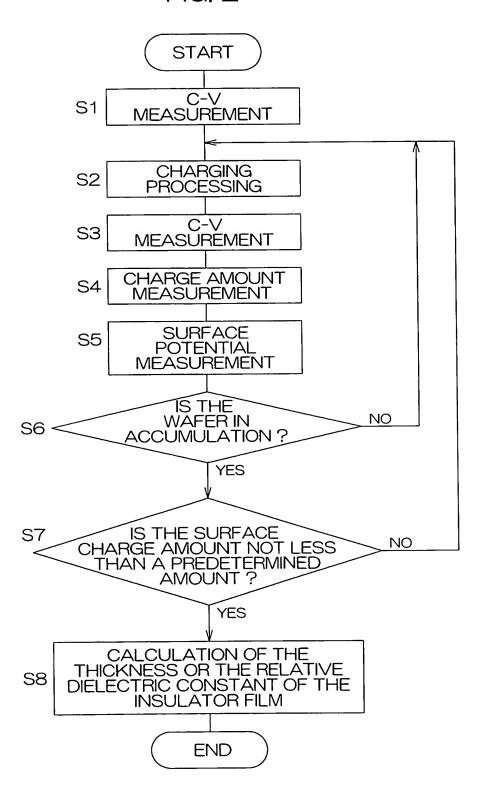


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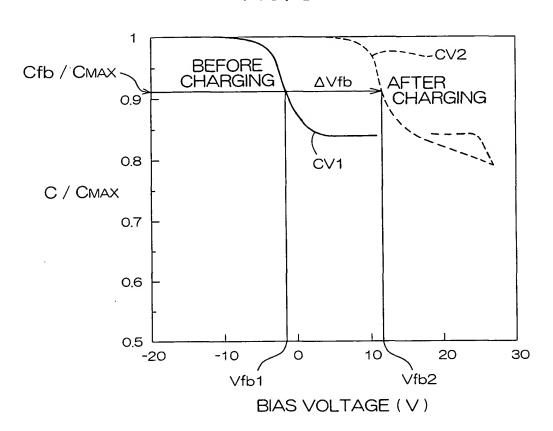
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FIG. 2



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FIG. 3



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